

Search Notes

Application/Control No.

10/624,327

Examiner

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Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
Update	search		
257	\$.cls.	2/4/2005	AH
438	\$.cls.		
365	\$.cls.		
Text	search	2/8/2005	AH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/4/2005	AH
EAST	2/8/2005	AH